

# **New Product**

# N-Channel Reduced $Q_g$ , Fast Switching MOSFET

| PRODUCT SUMMARY     |                                   |                    |  |  |
|---------------------|-----------------------------------|--------------------|--|--|
| V <sub>DS</sub> (V) | $r_{DS(on)}\left(\Omega\right)$   | I <sub>D</sub> (A) |  |  |
| 30                  | 0.0085 at V <sub>GS</sub> = 10 V  | 15                 |  |  |
|                     | 0.0125 at V <sub>GS</sub> = 4.5 V | 12                 |  |  |

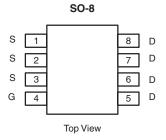
#### **FEATURES**

- TrenchFET® Gen II Power MOSFETS
- PWM Optimized
- 100 % R<sub>g</sub> Tested

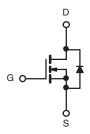


## **APPLICATIONS**

- High-Side DC/DC Conversion
  - Notebook
  - Desktop
  - Server



Ordering Information: Si4384DY-T1-E3 (Lead (Pb)-free)



N-Channel MOSFET

| ABSOLUTE MAXIMUM RATINGS  | <sub>A</sub> = 25 °C, unle | ess otherwise                     | noted       |              |      |
|---|----------------------------|-----------------------------------|-------------|--------------|------|
| Parameter   |                            | Symbol                            | 10 sec      | Steady State | Unit |
| Drain-Source Voltage  |                            | V <sub>DS</sub>                   | 30          |              | V    |
| Gate-Source Voltage   |                            | V <sub>GS</sub>                   | ± 20        |              |      |
| Continuous Drain Current /T 150 °C\8                            | T <sub>A</sub> = 25 °C     | I <sub>D</sub>                    | 15          | 10           |      |
| Continuous Drain Current (T <sub>J</sub> = 150 °C) <sup>a</sup> | T <sub>A</sub> = 70 °C     |                                   | 12          | 8            |      |
| Pulsed Drain Current  |                            | I <sub>DM</sub>                   | ± 50        |              | Α    |
| Continuous Source Current (Diode Conduction) <sup>a</sup>       |                            | I <sub>S</sub>                    | 2.8         | 1.3          |      |
| Single Pulse Avalanche Current                                  | L = 0.1 mH                 | I <sub>AS</sub>                   | 25          |              |      |
| Avalanche Energy  | L = 0.1 MH                 | E <sub>AS</sub> 31                |             | mJ           |      |
| Mariana Barra Biraira di ang                                    | T <sub>A</sub> = 25 °C     | P_                                | 3.1         | 1.47         | 10/  |
| Maximum Power Dissipation <sup>a</sup>                          | T <sub>A</sub> = 70 °C     |                                   | 2           | 0.95         | W    |
| Operating Junction and Storage Temperature Range                |                            | T <sub>J</sub> , T <sub>stg</sub> | - 55 to 150 |              | °C   |

| THERMAL RESISTANCE RATINGS                        |              |                     |         |         |      |  |
|---|--------------|---------------------|---------|---------|------|--|
| Parameter   |              | Symbol              | Typical | Maximum | Unit |  |
| Maximum Junction-to-Ambient (MOSFET) <sup>a</sup> | t ≤ 10 sec   | - R <sub>thJA</sub> | 34      | 40      | °C/W |  |
|   | Steady State |                     | 71      | 85      |      |  |
| Maximum Junction-to-Foot (Drain)                  | Steady State | $R_{thJF}$          | 17      | 20      |      |  |

#### Notes:

a. Surface Mounted on 1" x 1" FR4 Board.

# Vishay Siliconix



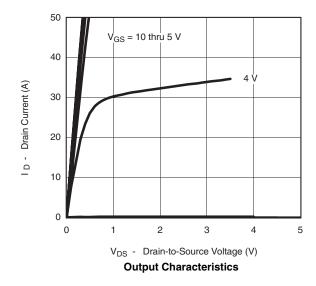
| Parameter                                     | Symbol              | Test Conditions  | Min         | Тур    | Max    | Unit |  |
|---|---------------------|--|-------------|--------|--------|------|--|
| Static  | •                   |  | ı           | , ,,   | 1      |      |  |
| Gate Threshold Voltage                        | V <sub>GS(th)</sub> | $V_{DS} = V_{GS}, I_D = 250 \mu A$   | 1.0         |        | 3.0    | V    |  |
| Gate-Body Leakage                             | I <sub>GSS</sub>    | $V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$                          |             |        | ± 100  | nA   |  |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>    | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$                              | '           |        | 1      |      |  |
|   |                     | $V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 70 ^{\circ}\text{C}$ |             |        | 10     | - μΑ |  |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>  | $V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$                            | 40          |        |        | Α    |  |
|   | r                   | V <sub>GS</sub> = 10 V, I <sub>D</sub> = 15 A                              | 0.007 0.008 |        | 0.0085 | Ω    |  |
| Drain-Source On-State Resistance <sup>a</sup> | r <sub>DS(on)</sub> | V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 12 A 0.0                         |             | 0.0105 | 0.0125 |      |  |
| Forward Transconductance <sup>a</sup>         | 9 <sub>fs</sub>     | V <sub>DS</sub> = 15 V, I <sub>D</sub> = 15 A                              |             | 56     |        | S    |  |
| Diode Forward Voltage <sup>a</sup>            | $V_{SD}$            | I <sub>S</sub> = 2.8 A, V <sub>GS</sub> = 0 V                              |             | 0.75   | 1.1    | V    |  |
| Dynamic <sup>b</sup>                          | '                   |  | •           |        |        |      |  |
| Total Gate Charge                             | Qg                  |  |             | 12     | 18     | nC   |  |
| Gate-Source Charge                            | $Q_{gs}$            | $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 15 \text{ A}$      |             | 5.9    |        |      |  |
| Gate-Drain Charge                             | $Q_{gd}$            |  |             | 4.0    |        | 1    |  |
| Gate Resistance                               | $R_{g}$             |  | 0.8         | 1.7    | 2.5    | Ω    |  |
| Turn-On Delay Time                            | t <sub>d(on)</sub>  |  |             | 10     | 15     |      |  |
| Rise Time                                     | t <sub>r</sub>      | $V_{DD}$ = 15 V, $R_L$ = 15 $\Omega$                                       |             | 13     | 20     | ns   |  |
| Turn-Off Delay Time                           | t <sub>d(off)</sub> | $I_D\cong$ 1 A, $V_{GEN}$ = 10 V, $R_g$ = 6 $\Omega$                       |             | 45     | 70     |      |  |
| Fall Time                                     | t <sub>f</sub>      |  |             | 13     | 20     |      |  |
| Source-Drain Reverse Recovery Time            | t <sub>rr</sub>     | I <sub>F</sub> = 2.8 A, di/dt = 100 A/μs                                   |             | 25     | 50     |      |  |

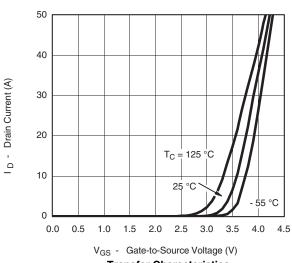
#### Notes:

- a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %.
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

# TYPICAL CHARACTERISTICS 25 °C unless noted





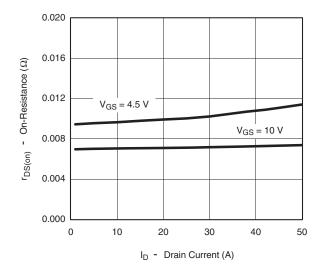
**Transfer Characteristics** 



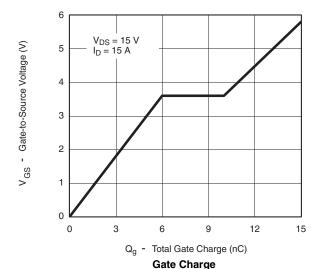


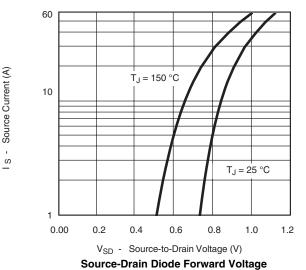


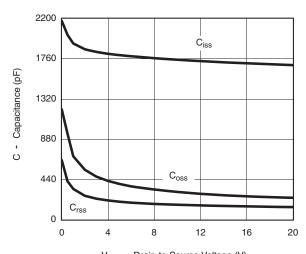
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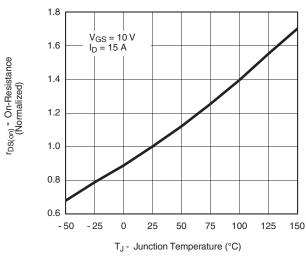
### On-Resistance vs. Drain Current



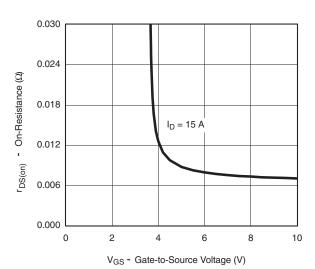




V<sub>DS</sub> - Drain-to-Source Voltage (V) **Capacitance** 



On-Resistance vs. Junction Temperature

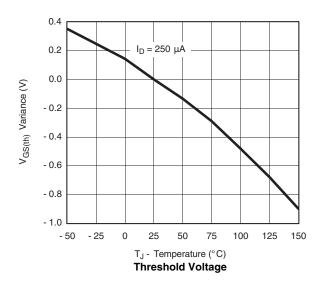


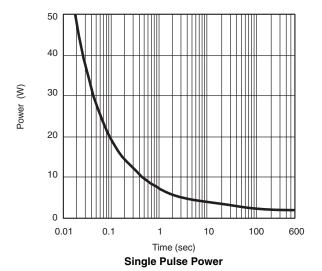
On-Resistance vs. Gate-to-Source Voltage

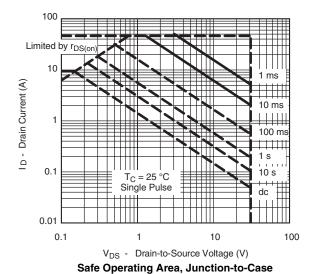
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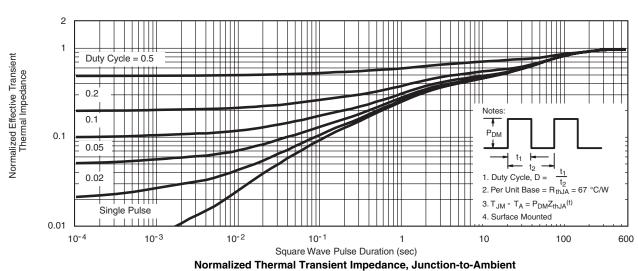
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## TYPICAL CHARACTERISTICS 25 °C unless noted



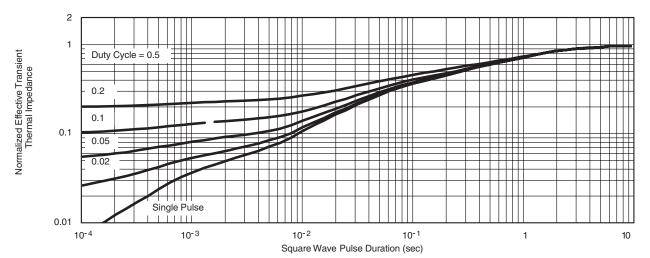








## TYPICAL CHARACTERISTICS 25 °C unless noted



Normalized Thermal Transient Impedance, Junction-to-Foot

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see <a href="http://www.vishay.com/ppg?72645">http://www.vishay.com/ppg?72645</a>



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